

Search Notes

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10/729,979

Examiner

Jinhee J. Lee

Applicant(s)/Patent under
Reexamination

CHIN, YUAN-CHANG

Art Unit

2174

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East text search attached	1/8/2007	LEE
IDS considered	1/23/2008	LEE